NI 622x Specifications

Specifications listed below are typical at 25 °C unless otherwise noted.

Analog Input

· · · · ·			
Number of channels		Input impedance	
NI 6220/NI 6221	. 8 differential or 16 single ended	AI+ to AI GND	>10 GΩ in parallel with 100 pF
NI 6224/NI 6229	. 16 differential or 32 single ended	AI- to AI GND	.>10 G Ω in parallel with 100 pF
ADC resolution	. 16 bits	Input bias current	±100 pA
DNL	. No missing codes	Crosstalk (at 100 kHz)	
	guaranteed	Adjacent channels	–75 dB
INL	. Refer to the AI	Non-adjacent channels	–90 dB
	Absolute Accuracy Table	Small signal bandwidth (–3 dB)	. 700 kHz
Sampling rate		Input FIFO size	4.095 samples
Maximum	. 250 KS/s	-	•
Minimum	. 0 S/s	Scan list memory	4,095 entries
Timing accuracy	• •	Data transfers	
Timing resolution	sample rate . 50 ns		(scatter-gather), interrupts,
Input coupling	DC		programmed I/O
input couping	DC	Overvoltage protection	
Input range		(AI <031>, AI SENSE, A	SENSE 2)
	$\pm 1 \text{ V}, \pm 0.2 \text{ V}$	Device on	±25 V for up to
Maximum working voltage			two AI pins
for analog inputs		Device off	
(signal + common mode)	. ±11 V of AI GND		two AI pins
CMRR (DC to 60 Hz)	. 95 dB	Input current during overvoltage condition	±20 mA max/AI pin



Settling Time for Multichannel Measurements

Accuracy, full scale step, all ranges

±90 ppm of step

(±6 LSB).....4 μs convert interval

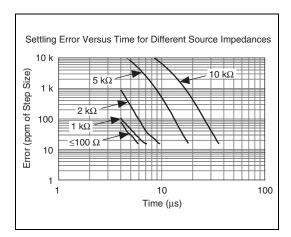
 ± 30 ppm of step

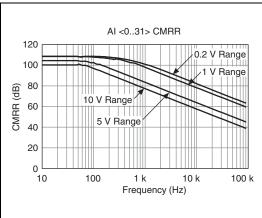
(±2 LSB).....5 μs convert interval

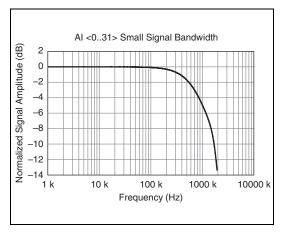
 ± 15 ppm of step

(±1 LSB).....7 μs convert interval

Typical Performance Graphs







Analog Output

Number of channels NI 6220
DAC resolution 16 bits
DNL±1 LSB
Monotonicity 16 bit guaranteed
Maximum update rate 1 channel
Timing accuracy 50 ppm of sample rate
Timing resolution 50 ns
Output range±10 V
Output couplingDC
Output impedance 0.2Ω
Output current drive±5 mA
Overdrive protection±25 V
Overdrive current 10 mA
Power-on state±20 mV
Power-on glitch 8.5 V peak for 14.5 ms
Output FIFO size
Data transfers

AO waveform modes:

- Non-periodic waveform
- Periodic waveform regeneration mode from onboard FIFO
- Period waveform regeneration from host buffer including dynamic update

Settling time, full scale step 15 ppm (1 LSB)6 µs
Slew rate 15 V/μs
Glitch energy
Magnitude 100 mV
Duration2.6 μs

Calibration (Al and AO)

Recommended	
warm-up time	15 minutes
Calibration interval	1 year

Al Absolute Accuracy Table

Nomina	Nominal Range				Residual	1				
Positive Full Scale	Negative Full Scale	Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INLError (ppm of Range)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale ¹ (μV)	Sensitivity² (µV)
10	-10	75	25	5	20	57	92	244	3,100	9.76
5	5-	85	25	5	20	09	92	122	1,620	48.8
1	-1	56	25	5	25	62	92	30	360	12.0
0.2	-0.2	135	25	5	08	175	92	13	112	5.2

Absolute Accuracy = Reading \cdot (Gain Error) + Range \cdot (Offset Error) + Noise Uncertainty

GainError = ResidualAlGainError + GainTempco · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal) OffsetError = ResidualAIOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INL_Error

For a coverage factor of 3 σ and averaging 100 points. NoiseUncertainty = RandomNoise · 3

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

TempChangeFromLastExternalCal = 10 °C

TempChangeFromLastInternalCal = 1 °C

 $number_of_readings = 100$

CoverageFactor = 3σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

OffsetError = $20 \text{ ppm} + 57 \text{ ppm} \cdot 1 + 76 \text{ ppm}$

GainError = 75 ppm + 25 ppm \cdot 1 + 5 ppm \cdot 10

OffsetError = 153 ppm

GainError = 150 ppm

NoiseUncertainty = $73 \mu V$ NoiseUncertainty = $\frac{244 \mu \text{V} \cdot 3}{1}$ Absolute Accuracy = $3,100 \,\mu\text{V}$ AbsoluteAccuracy = $10 \text{ V} \cdot (\text{GainError}) + 10 \text{ V} \cdot (\text{OffsetError}) + \text{NoiseUncertainty}$

² Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

AO Absolute Accuracy Table

Range					Residual			Absolute
		Residual Gain			Offset Error	Offset Tempco	INL Error	Accuracy at
Z	Vegative	Error (ppm of	Gain Tempco	Reference	Jo mdd)	Jo mdd)	Jo mdd)	Full Scale ¹
F	ull Scale	Reading)	(ppm/°C)	Tempco	Range)	Range/°C)	Range)	(μ V)
	0,	90	0	1	07	-		0000
	-I0	35	10	c	40	n	128	3,230

Absolute Accuracy at full scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.

 $AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$

 $GainError = Residual GainError + GainTempco \cdot (TempChangeFromLastInternalCal) + ReferenceTempco \cdot (TempChangeFromLastExternalCal) + ReferenceTempco \cdot (TempChangeFromLastExt$ $OffsetError = Residual OffsetError + AOOffsetTempco \cdot (TempChangeFromLastInternalCal) + INL_Error + AOOffsetError + AOOffsetTempco \cdot (TempChangeFromLastInternalCal) + INL_Error + AOOffsetError + AOOffsetTempco \cdot (TempChangeFromLastInternalCal) + INL_Error + AOOffsetTempco \cdot (TempChangeFromLastInternalCal) + INL_Error + AOOffsetTempco \cdot (TempChangeFromLastInternalCal) + A$

Digital I/O/PFI

Static Characteristics

Number of channels

NI 6220/NI 622124 total 8 (P0.<0..7>) 16 (PFI <0..15>/ P1/P2)

NI 6224/NI 622948 total

32 (P0.<0..31>) 16 (PFI <0..15>/

P1/P2)

Ground reference D GND

Direction controlEach terminal individually

programmable as input or output

Pull-down resistor50 k Ω to 75 k Ω

Input voltage protection¹.....±20 V on up to two pins

DO or DI Sample

Clock source...... Any PFI, RTSI, AI Sample or

Convert Clock, AO Sample Clock, DI Change Event, Ctr n Internal

Output, and many

other signals

PFI/Port 1/Port 2 Functionality

Functionality Static digital input,

static digital output, timing input,

timing output

Timing output sources...... Many AI, AO,

counter, DI,

DO timing signals

Debounce filter settings 125 ns, 6.425 µs,

2.54 ms, disable; high and low transitions:

selectable per input

Waveform Characteristics (Port 0 Only)

Terminals used

NI 6220/NI 6221Port 0 (P0.<0..7>) NI 6224/NI 6229Port 0 (P0.<0..31>)

Port/sample size

NI 6220/NI 6221Up to 8 bits NI 6224/NI 6229Up to 32 bits

Waveform generation

(DO) FIFO2,047 samples

Waveform acquisition

(DI) FIFO2,047 samples

DO or DI Sample

Clock frequency......0 to 1 MHz

¹ Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

NI 622x Specifications 6 ni.com

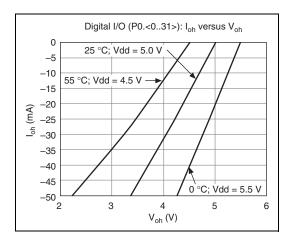
Recommended Operation Conditions

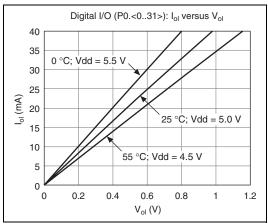
Level	Min	Max
Input high voltage (V _{IH})	2.2 V	5.25 V
Input low voltage (V _{IL})	0 V	0.8 V
Output high current (I _{OH})		
P0.<031>	_	-24 mA
PFI <015>/P1/P2	_	-16 mA
Output low current (I _{OL})		
P0.<031>	_	24 mA
PFI <015>/P1/P2	_	16 mA

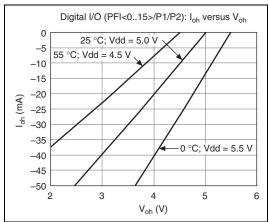
Electrical Characteristics

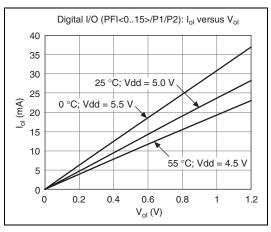
Level	Min	Max
Positive-going threshold (VT+)	_	2.2 V
Negative-going threshold (VT–)	0.8 V	_
Delta VT hysteresis (VT+ – VT–)	0.2 V	_
I_{IL} input low current $(V_{in} = 0 \text{ V})$	_	–10 μA
I_{IH} input high current ($V_{in} = 5 \text{ V}$)	_	250 μΑ

Digital I/O Characteristics









General-Purpos Counter/Timers		Frequency Gen Number of channels	
Number of counter/timers		Base clocks	. 10 MHz, 100 kHz
Resolution	32 bits	Divisors	. 1 to 16
Counter measurements		Base clock accuracy	50 ppm
	pulse, semi-period, period, two-edge separation	Output can be available on terminal.	any PFI or RTSI
Position measurements	X1, X2, X4 quadrature encoding with Channel Z	Phase-Locked I	• \
	reloading; two-pulse encoding	Reference signal	.PXI_STAR, PXI_CLK10,
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling	Output of PLL	RTSI <07> . 80 MHz timebase; other signals derived from 80 MHz timebase including
Internal base clocks	80 MHz, 20 MHz, 0.1 MHz		20 MHz and 100 kHz timebases
External base clock frequency	0 MHz to 20 MHz	External Digita	
Base clock accuracy	50 ppm	Source	. Any PFI, RTSI, PXI_TRIG,
Inputs			PXI_STAR
	HW_Arm, Aux, A, B, Z, Up_Down	Polarity	. Software-selectable for most signals
Routing options for inputs	PXI_TRIG, PXI_STAR, analog trigger, many internal signals	Analog input function	. Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock
FIFO	_		Timebase
Data transfers	Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O	Analog output function	. Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase

Counter/timer functions	.Gate, Source,	Power Requires	ments
	HW_Arm, Aux, A, B, Z, Up_Down,	Current draw from bus during	
	•	+5 V	0.02 A
Digital waveform generation		+3.3 V	0.25 A
(DO) function	.Sample Clock	+12 V	
Digital waveform acquisitio	n		0,10,11
(DI) function	.Sample Clock	Current draw from bus during overvoltage condition	ng AI and AO
Device-To-Device T	rigger Bus	+5 V	0.02 A
PCI devices		+3.3 V	0.25 A
		+12 V	0.25 A
PXI devices		Danier and 1212 form	
	PXI_STAR	Power available from +5 V terminal	1 Δ may each
Output selections	.10 MHz Reference	+5 V terminar	connector, with
	Clock; frequency		self-resetting fuse
	generator output;	0.1	C
	many internal	Other power limit for PXI devices	Current drawn from
	signals	rai devices	+5 V terminals and
Debounce filter settings	.125 ns, 6.425 μs,		all P0/PFI/P1/P2
	2.54 ms, disabled;		terminals should not
	high and low		exceed 2 A
	transitions; selectable per input		
	selectable per input	Physical Require	rements
Bus Interface		Printed circuit board dimens	sions
	2.2 V on 5 V signal	NI PCI 6220/6221/	
PCI or PXI	environment	6224/6229	
			$(3.8 \text{ in.} \times 6.1 \text{ in.})$
DMA channels		NI PXI 6220/6221/	
	analog output,	6224/6229	Standard 3U PXI
	digital input, digital output,	I/O connector	
	digital output,	NH (220/NH (221	1.60 WHDCI

counter/timer 0,

counter/timer 1

NI 6220/NI 6221 1 68-pin VHDCI

NI 6224/NI 6229 2 68-pin VHDCI

¹ In other sections of this document, *RTSI* refers to RTSI <0..7> for PCI devices or PXI_TRIG <0..7> for PXI devices.

Maximum Working Voltage¹

NI 6220/NI 6221/NI 6224/NI 6229

Category I

Environmental

Operating temperature0 to 55 °C

Storage temperature20 to 70 °C

Humidity10 to 90% RH, noncondensing

Maximum altitude2,000 m

Pollution Degree (indoor use only)2

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1
- CAN/CSA C22.2 No. 61010-1



Note For UL and other safety certifications, refer to the product label, or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

CE, C-Tick, and FCC Part 15 (Class A) Compliant



Note For EMC compliance, operate this device with shielded cabling.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

Low-Voltage Directive	
(safety)	73/23/EEC
Electromagnetic Compa	atibility
Directive (EMC)	89/336/EEC



Note Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

¹ Maximum working voltage refers to the signal voltage plus the common-mode voltage.





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